

TRANSISTOR

AC/DC ISOLATION TESTER AC/DC耐圧試験器

TACD5000IG AC=5000V
DC=1000V

NEW



- TACD5000IG is tester for measure voltage tolerance of semiconductor package with both measurement method of AC and DC. Either measurement mode of the detection of the voltage peak or the detection with VRMS (actual effect value) can be chosen in the AC test.
- 半導体パッケージの耐電圧をAC及びDCの両測定法にてテストする試験器です。ACテストにおいて、電圧ピークの検出、またはVRMS(実効値)での検出のどちらかの測定モードを選択できます。

MODEL	TACD5000IG	
SETTING RANGE		
AC	AC FORCING VOLTAGE	0.01kV~5.00kV(0.01kV STEP)
	AC FORCING TIME	0.1s~3.9s(0.1sec STEP)
	IAC-LIMIT	1 μ A~1999 μ A(1 μ A STEP)
DC	DC FORCING VOLTAGE	500V, 1000V
	DC FORCING TIME	0.1s~3.9s(0.1sec STEP)
	R-LIMIT	1M Ω ~999M Ω (1M Ω STEP)
EXT CONTROL I/F	IEEE-488 I/F STANDARD(GP-IB)	
DIMENSIONS & WEIGHT		
MAIN UNIT	430(W) \times 550(D) \times 245(H)···37kg	